

## MAX232E 具有 IEC61000-4-2 保护的双路 RS-232 驱动器和接收器

## 1 特性

- 符合或超出 TIA/RS-232-F 和 ITU 建议 V.28 的要求
- 为 RS-232 总线引脚提供 ESD 保护
  - ±15kV 人体放电模型 (HBM)
  - ±8kV IEC61000-4-2, 接触放电
  - ±15kV IEC61000-4-2, 气隙放电
- 通过带 1μF 电荷泵电容器的单个 5V 电源供电
- 速率高达 250kbit/s
- 两个驱动器和两个接收器
- 低电源电流: 8mA (典型值)

## 2 应用

- TIA/RS-232-F
- 电池供电型系统
- 端子
- 调制解调器
- 计算机

## 3 说明

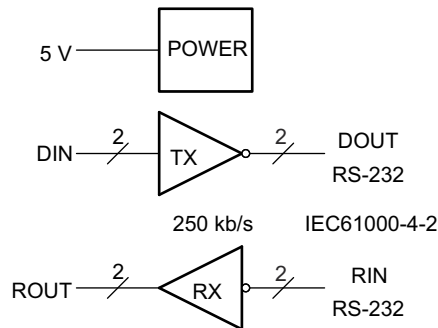
MAX232E 是一款双路驱动器和接收器, 它包含一个电容式电压发生器, 可通过单个 5V 电源提供符合 RS-232-F 标准的电压电平。每个接收器都将 RS-232 输入转换为 5V TTL/CMOS 电平。该接收器的典型阈值为 1.3V, 典型迟滞为 0.5V, 可接受 ±30V 输入。每个驱动器都将 TTL/CMOS 输入电平转换为 TIA/RS-232-F 电平。

## 封装信息

| 器件型号   | 封装 <sup>(1)</sup> | 封装尺寸 <sup>(2)</sup> |
|--------|-------------------|---------------------|
| MAX232 | SOIC (16)         | 9.9mm x 6mm         |
|        | SOIC (16)         | 10.4mm x 10.3mm     |
|        | PDIP (16)         | 19.3mm x 9mm        |
|        | SOP (16)          | 10.2mm x 7.8 mm     |

(1) 如需更多信息, 请参阅节 10。

(2) 封装尺寸 (长 × 宽) 为标称值, 并包括引脚 (如适用)。



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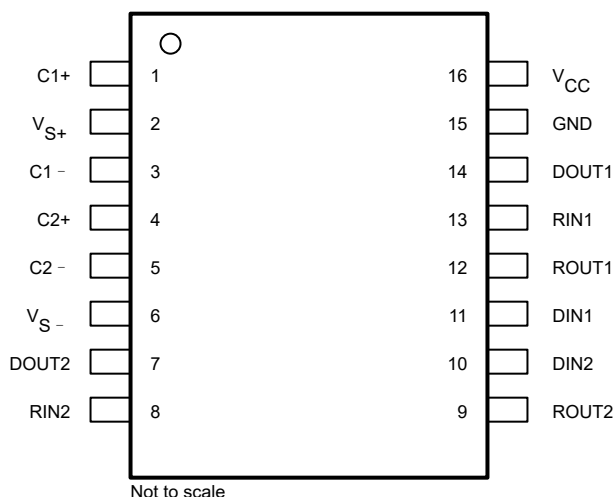
逻辑图 (正逻辑)



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## 4 Pin Configuration and Functions



**图 4-1. D (SOIC) , DW (SOIC), N (PDIP), or PW (TSSOP) 16-Pin Package (Top View)**

**表 4-1. Pin Functions**

| PIN |          | TYPE | DESCRIPTION                                            |
|-----|----------|------|--------------------------------------------------------|
| NO. | NAME     |      |                                                        |
| 1   | C1+      | —    | Positive lead of C1 capacitor                          |
| 2   | $V_{S+}$ | O    | Positive charge pump output for storage capacitor only |
| 3   | C1 -     | —    | Negative lead of C1 capacitor                          |
| 4   | C2+      | —    | Positive lead of C2 capacitor                          |
| 5   | C2 -     | —    | Negative lead of C2 capacitor                          |
| 6   | $V_{S-}$ | O    | Negative charge pump output for storage capacitor only |
| 7   | DOUT2    | O    | RS-232 line data output (to remote RS-232 system)      |
| 8   | RIN2     | I    | RS-232 line data input (from remote RS-232 system)     |
| 9   | ROUT2    | O    | Logic data output (to UART)                            |
| 10  | DIN2     | I    | Logic data input (from UART)                           |
| 11  | DIN1     | I    | Logic data input (from UART)                           |
| 12  | ROUT1    | O    | Logic data output (to UART)                            |
| 13  | RIN1     | I    | RS-232 line data input (from remote RS-232 system)     |
| 14  | DOUT1    | O    | RS-232 line data output (to remote RS-232 system)      |
| 15  | GND      | —    | Ground                                                 |
| 16  | $V_{CC}$ | —    | Supply voltage, connect to external 5V power supply    |

## 5 Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                  |                                        | MIN                   | MAX                   | UNIT      |
|------------------|----------------------------------------|-----------------------|-----------------------|-----------|
| V <sub>CC</sub>  | Input supply voltage <sup>(2)</sup>    | - 0.3                 | 6                     | V         |
| V <sub>S+</sub>  | Positive output supply voltage         | V <sub>CC</sub> - 0.3 | 15                    | V         |
| V <sub>S-</sub>  | Negative output supply voltage         | - 0.3                 | - 15                  | V         |
| V <sub>I</sub>   | Input voltage                          | - 0.3                 | V <sub>CC</sub> + 0.3 | V         |
|                  |                                        |                       | ±30                   |           |
| V <sub>O</sub>   | Output voltage                         | V <sub>S-</sub> - 0.3 | V <sub>S+</sub> + 0.3 | V         |
|                  |                                        | - 0.3                 | V <sub>CC</sub> + 0.3 |           |
|                  | Short-circuit duration                 | DOUT                  |                       | Unlimited |
| T <sub>J</sub>   | Operating virtual junction temperature |                       | 150                   | °C        |
| T <sub>stg</sub> | Storage temperature                    | - 65                  | 150                   | °C        |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to network GND.

### 5.2 ESD Ratings

|                    |                         |                                                                                | VALUE                 | UNIT   |
|--------------------|-------------------------|--------------------------------------------------------------------------------|-----------------------|--------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | Pins 7, 8, 13, and 14 | ±15000 |
|                    |                         |                                                                                | Other pins            | ±3000  |
|                    |                         | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | All pins              | ±1500  |
|                    |                         | IEC61000-4-2, air-gap discharge                                                | Pins 7, 8, 13, and 14 | ±15000 |
|                    |                         | IEC61000-4-2, contact discharge                                                |                       | ±8000  |

- (1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

### 5.3 Recommended Operating Conditions

|                 |                                       | MIN      | NOM | MAX  | UNIT |
|-----------------|---------------------------------------|----------|-----|------|------|
| V <sub>CC</sub> | Supply voltage                        | 4.5      | 5   | 5.5  | V    |
| V <sub>IH</sub> | High-level input voltage (DIN1, DIN2) | 2        |     |      | V    |
| V <sub>IL</sub> | Low-level input voltage (DIN1, DIN2)  |          |     | 0.8  | V    |
|                 | Receiver input voltage (RIN1, RIN2)   | ±3       |     | ±30  | V    |
| T <sub>A</sub>  | Operating free-air temperature        | MAX232EC |     | 0    | °C   |
|                 |                                       | MAX232EI |     | - 40 |      |

## 5.4 Thermal Information

| THERMAL METRIC <sup>(1) (2) (3)</sup> |                                              | D<br>(SOIC) | DW<br>(SOIC) | N<br>(PDIP) | PW<br>(TSSOP) | UNIT |
|---------------------------------------|----------------------------------------------|-------------|--------------|-------------|---------------|------|
|                                       |                                              | 16 PINS     | 16 PINS      | 16 PINS     | 16 PINS       |      |
| $R_{\theta JA}$                       | Junction-to-ambient thermal resistance       | 84.6        | 73.4         | 60.6        | 107.5         | °C/W |
| $R_{\theta JC(top)}$                  | Junction-to-case (top) thermal resistance    | 43.5        | 35.1         | 48.1        | 38.4          | °C/W |
| $R_{\theta JB}$                       | Junction-to-board thermal resistance         | 43.2        | 38.3         | 40.6        | 53.7          | °C/W |
| $\psi_{JT}$                           | Junction-to-top characterization parameter   | 10.4        | 9.4          | 27.5        | 3.2           | °C/W |
| $\psi_{JB}$                           | Junction-to-board characterization parameter | 42.8        | 37.7         | 40.3        | 53.1          | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.
- (2) Maximum power dissipation is a function of  $T_J(max)$ ,  $R_{\theta JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_J(max) - T_A)/R_{\theta JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can affect reliability.
- (3) The package thermal impedance is calculated in accordance with JESD 51-7.

## 5.5 Electrical Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see [Figure 7-1](#))

| PARAMETER               | TEST CONDITIONS <sup>(1)</sup>                                     | MIN | TYP <sup>(2)</sup> | MAX | UNIT |
|-------------------------|--------------------------------------------------------------------|-----|--------------------|-----|------|
| $I_{CC}$ Supply current | $V_{CC} = 5.5\text{ V}$ All outputs open, $T_A = 25^\circ\text{C}$ |     | 8                  | 10  | mA   |

- (1) Test conditions are  $C1 - C4 = 1\mu\text{F}$  at  $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ .
- (2) All typical values are at  $V_{CC} = 5\text{ V}$  and  $T_A = 25^\circ\text{C}$ .

## 5.6 Electrical Characteristics: Driver

over recommended ranges of supply voltage and operating free-air temperature range

| PARAMETER               |                                         | TEST CONDITIONS <sup>(1)</sup> | MIN                                               | TYP <sup>(2)</sup> | MAX | UNIT          |
|-------------------------|-----------------------------------------|--------------------------------|---------------------------------------------------|--------------------|-----|---------------|
| $V_{OH}$                | High-level output voltage               | DOUT                           | $R_L = 3\text{ k}\Omega$ to GND                   | 5                  | 7   | V             |
| $V_{OL}$                | Low-level output voltage <sup>(3)</sup> | DOUT                           | $R_L = 3\text{ k}\Omega$ to GND                   | -7                 | -5  | V             |
| $r_o$                   | Output resistance                       | DOUT                           | $V_{S+} = V_{S-} = 0$ ,<br>$V_O = \pm 2\text{ V}$ | 300                |     | $\Omega$      |
| $I_{OS}$ <sup>(4)</sup> | Short-circuit output current            | DOUT                           | $V_{CC} = 5.5\text{ V}$ ,<br>$V_O = 0$            | $\pm 10$           |     | mA            |
| $I_{IS}$                | Short-circuit input current             | DIN                            | $V_I = 0$                                         |                    | 200 | $\mu\text{A}$ |

- (1) Test conditions are  $C1 - C4 = 1\mu\text{F}$  at  $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ .
- (2) All typical values are at  $V_{CC} = 5\text{ V}$  and  $T_A = 25^\circ\text{C}$ .
- (3) The algebraic convention, in which the least-positive (most negative) value is designated minimum, is used in this data sheet for logic voltage levels only.
- (4) Not more than one output should be shorted at a time.

## 5.7 Electrical Characteristics: Receiver

over recommended ranges of supply voltage and operating free-air temperature range

| PARAMETER |                                                 | TEST CONDITIONS <sup>(1)</sup> | MIN                                               | TYP <sup>(2)</sup> | MAX | UNIT |
|-----------|-------------------------------------------------|--------------------------------|---------------------------------------------------|--------------------|-----|------|
| $V_{OH}$  | High-level output voltage                       | ROUT                           | $I_{OH} = -1\text{ mA}$                           | 3.5                |     | V    |
| $V_{OL}$  | Low-level output voltage                        | ROUT                           | $I_{OL} = 3.2\text{ mA}$                          |                    | 0.4 | V    |
| $V_{IT+}$ | Receiver positive-going input threshold voltage | RIN                            | $V_{CC} = 5\text{ V}$<br>$T_A = 25^\circ\text{C}$ | 1.7                | 2.4 | V    |
| $V_{IT-}$ | Receiver negative-going input threshold voltage | RIN                            | $V_{CC} = 5\text{ V}$<br>$T_A = 25^\circ\text{C}$ | 0.8                | 1.2 | V    |
| $V_{hys}$ | Input hysteresis voltage                        | RIN                            | $V_{CC} = 5\text{ V}$                             | 0.2                | 0.5 | 1    |
| $r_i$     | Receiver input resistance                       | RIN                            | $V_{CC} = 5\text{ V}$<br>$T_A = 25^\circ\text{C}$ | 3                  | 5   | 7    |

- (1) Test conditions are  $C1 - C4 = 1\mu\text{F}$  at  $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ .
- (2) All typical values are at  $V_{CC} = 5\text{ V}$  and  $T_A = 25^\circ\text{C}$ .

## 5.8 Switching Characteristics: Driver

$V_{CC} = 5V$ ,  $T_A = 25^\circ C$

| PARAMETER |                                    | TEST CONDITIONS <sup>(1)</sup>                | MIN | TYP | MAX | UNIT       |
|-----------|------------------------------------|-----------------------------------------------|-----|-----|-----|------------|
| SR        | Driver slew rate                   | $R_L = 3k\Omega$ to $7k\Omega$ , See 图 6-2    |     |     | 30  | V/ $\mu s$ |
| SR(t)     | Driver transition region slew rate | $R_L = 3k\Omega$ , $C_L = 2.5nF$<br>See 图 6-3 |     | 3   |     | V/ $\mu s$ |
|           | Data rate                          | One DOUT switching                            |     | 250 |     | kbit/s     |

(1) Test conditions are  $C_1 - C_4 = 1\mu F$  at  $V_{CC} = 5V \pm 0.5V$ .

## 5.9 Switching Characteristics: Receiver

$V_{CC} = 5V$ ,  $T_A = 25^\circ C$  (see 图 6-1)

| PARAMETER    |                                                            | TEST CONDITIONS <sup>(1)</sup> | TYP | UNIT |
|--------------|------------------------------------------------------------|--------------------------------|-----|------|
| $t_{PLH(R)}$ | Receiver propagation delay time, low- to high-level output | $C_L = 50pF$                   | 500 | ns   |
| $t_{PHL(R)}$ | Receiver propagation delay time, high- to low-level output | $C_L = 50pF$                   | 500 | ns   |

(1) Test conditions are  $C_1 - C_4 = 1\mu F$  at  $V_{CC} = 5V \pm 0.5V$ .

## 5.10 Typical Characteristics

$T_A = 25\text{ }^\circ\text{C}$

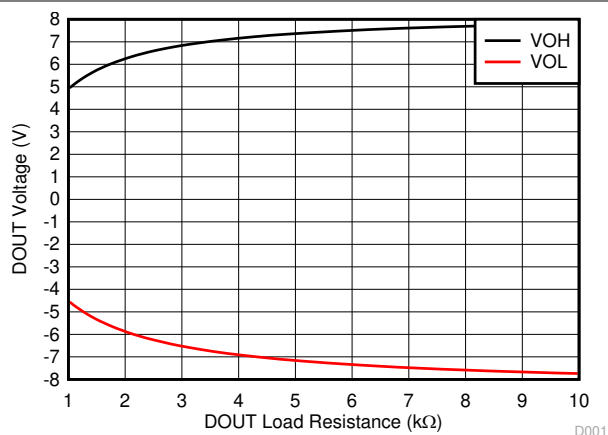


图 5-1. Driver Output Voltage vs Load Resistance

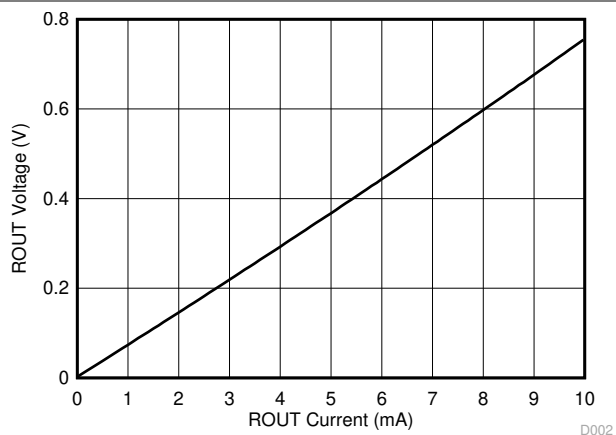


图 5-2. Receiver Low Output Voltage vs Load Current

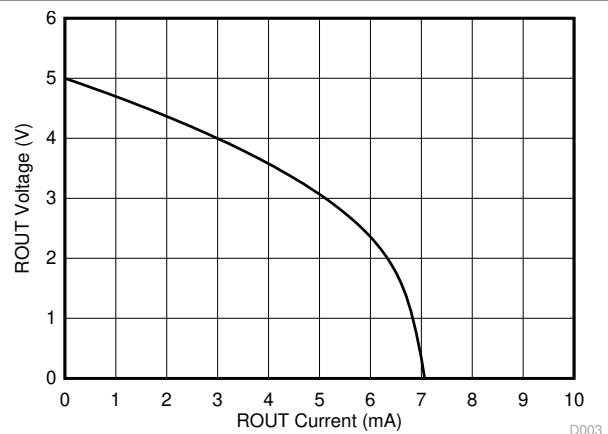


图 5-3. Receiver High Output Voltage vs Load Current

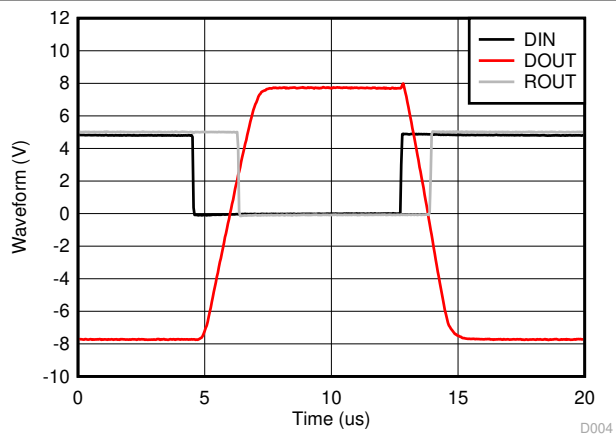
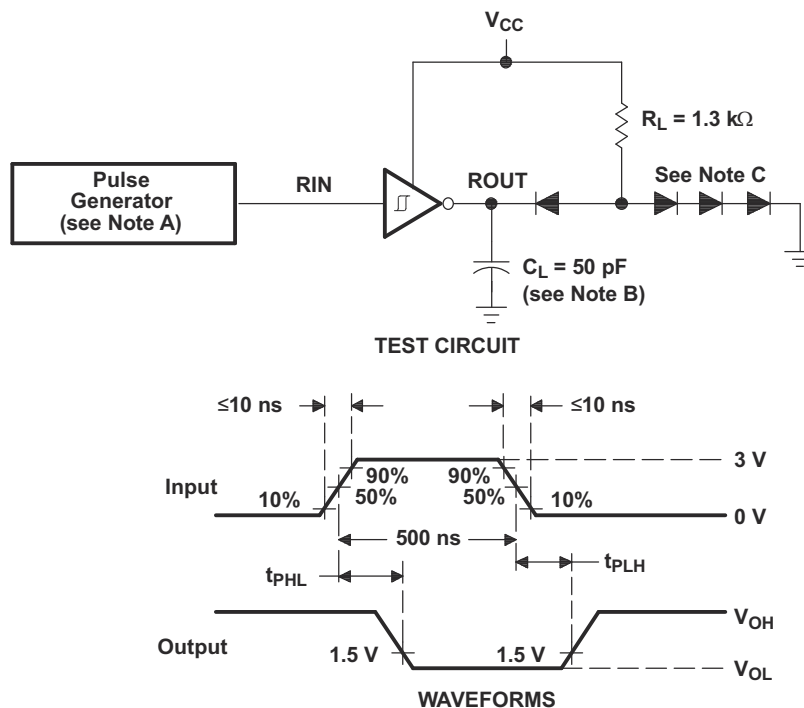
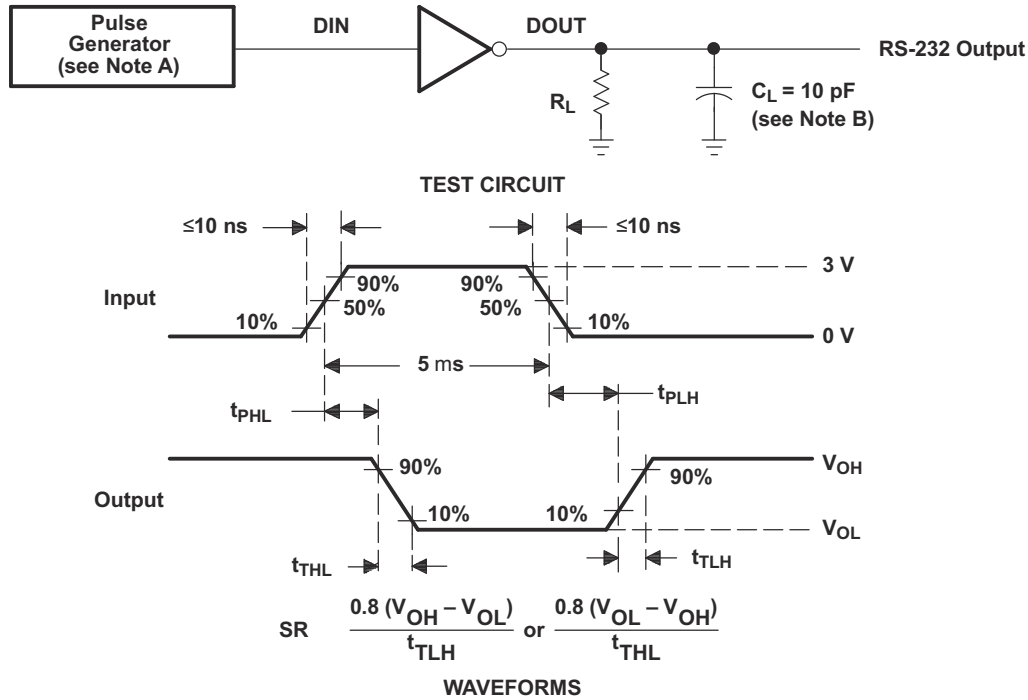


图 5-4. Loopback Waveforms Data Rate 120 kbit/s



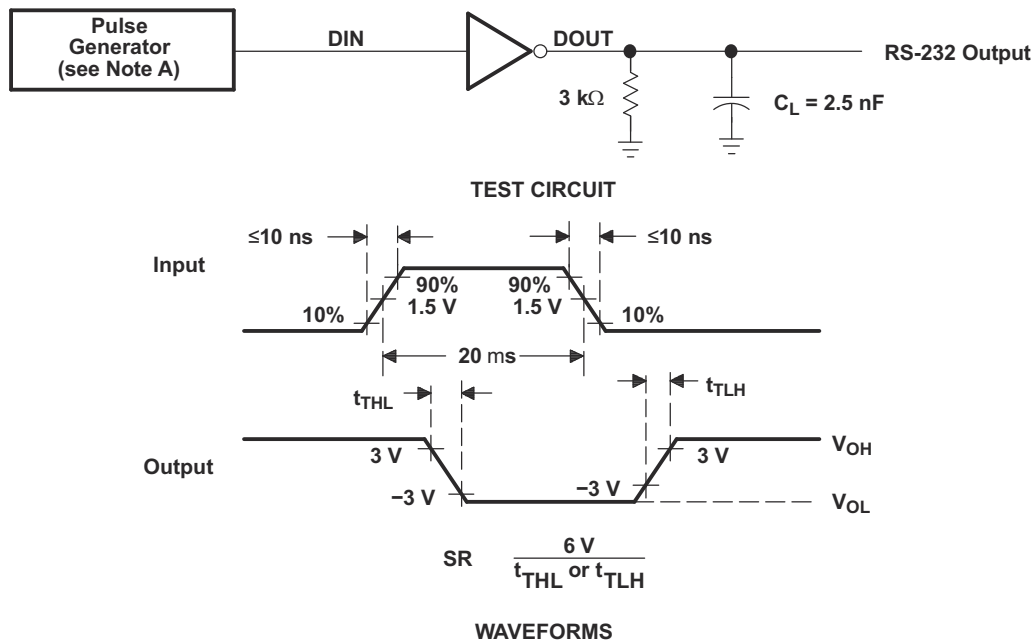
- A. The pulse generator has the following characteristics:  $Z_O = 50 \Omega$ , duty cycle  $\leq 50\%$ .
- B.  $C_L$  includes probe and jig capacitance.
- C. All diodes are 1N3064 or equivalent.

**图 6-1. Receiver Test Circuit and Waveforms for  $t_{PHL}$  and  $t_{PLH}$  Measurements**



- A. The pulse generator has the following characteristics:  $Z_O = 50 \Omega$ , duty cycle  $\leq 50\%$ .  
B.  $C_L$  includes probe and jig capacitance.

**图 6-2. Driver Test Circuit and Waveforms for  $t_{PHL}$  and  $t_{PLH}$  Measurements (5- $\mu\text{s}$  Input)**



- A. The pulse generator has the following characteristics:  $Z_O = 50 \Omega$ , duty cycle  $\leq 50\%$ .

**图 6-3. Test Circuit and Waveforms for  $t_{THL}$  and  $t_{TLH}$  Measurements (20- $\mu\text{s}$  Input)**

## 6 Detailed Description

### 6.1 Overview

The MAX232E is a dual driver and receiver that includes a capacitive voltage generator using four capacitors to supply TIA/EIA-232-F voltage levels from a single 5V supply. All RS-232 pins have 15kV HBM and IEC61000-4-2 Air-Gap discharge protection. RS-232 pins also have 8kV IEC61000-4-2 contact discharge protection. Each receiver converts TIA/EIA-232-F inputs to 5V TTL/CMOS levels. These receivers have shorted and open fail safe. The receiver can accept up to  $\pm 30\text{V}$  inputs and decode inputs as low as  $\pm 3\text{V}$ . Each driver converts TTL/CMOS input levels into TIA/EIA-232-F levels. Outputs are protected against shorts to ground.

### 6.2 Functional Block Diagram

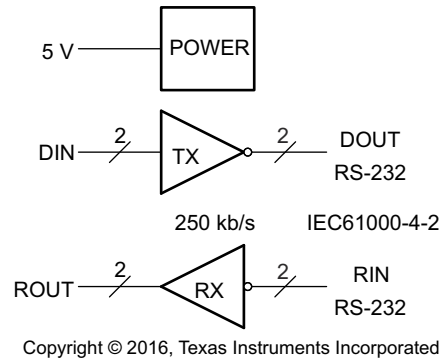


图 6-1. Logic Diagram (Positive Logic)

### 6.3 Feature Description

#### 6.3.1 Power

The power block increases and inverts the 5V supply for the RS-232 driver using a charge pump that requires four  $1\mu\text{F}$  external capacitors.

#### 6.3.2 RS-232 Driver

Two drivers interface standard logic level to RS-232 levels. Internal pullup resistors on DIN inputs ensures a high input when the line is high impedance.

#### 6.3.3 RS-232 Receiver

Two receivers interface RS-232 levels to standard logic levels. An open or shorted to ground input results in a high output on ROUT.

## 6.4 Device Functional Modes

### 6.4.1 V<sub>CC</sub> Powered by 5V

The device is in normal operation.

### 6.4.2 V<sub>CC</sub> Unpowered

When MAX232E is unpowered, it can be safely connected to an active remote RS-232 device.

### 6.4.3 Truth Tables

表 6-1 and 表 6-2 list the functions of this device.

**表 6-1. Function Table for Each Driver**

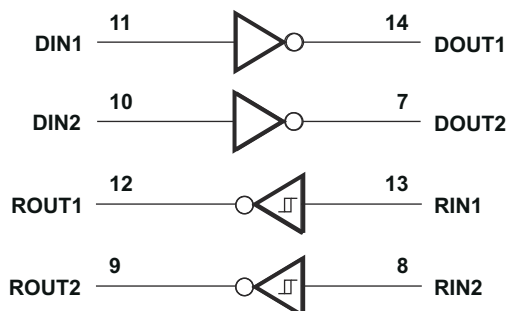
| INPUT<br>DIN <sup>(1)</sup> | OUTPUT<br>DOUT |
|-----------------------------|----------------|
| L                           | H              |
| H                           | L              |

(1) H = high level, L = low level

**表 6-2. Function Table for Each Receiver**

| INPUT<br>RIN <sup>(1)</sup> | OUTPUT<br>ROUT |
|-----------------------------|----------------|
| L                           | H              |
| H                           | L              |
| Open                        | H              |

(1) H = high level, L = low level, Open = input disconnected or connected driver off



**图 6-2. Logic Diagram (Positive Logic)**

## 7 Applications and Implementation

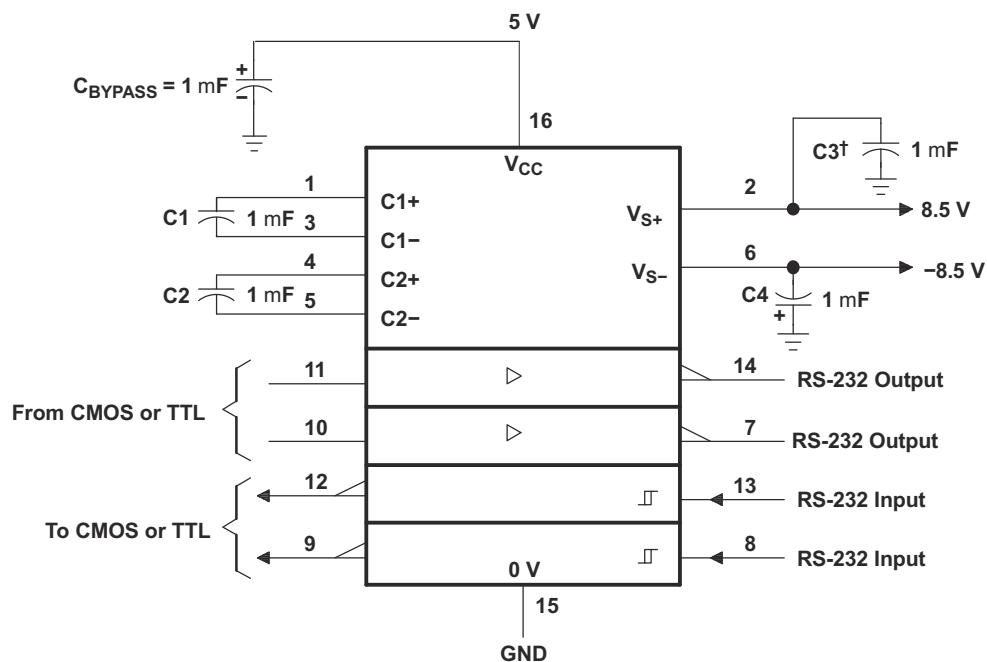
### 备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

### 7.1 Application Information

For proper operation add capacitors as shown in 图 7-1. Pins 9 through 12 connect to UART or general purpose logic lines. RS-232 lines on pins 7, 8, 13, and 14 connect to a connector or cable.

### 7.2 Typical Application



† C3 can be connected to  $V_{CC}$  or GND.

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Resistor values shown are nominal.

Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

图 7-1. Typical Operating Circuit

#### 7.2.1 Design Requirements

- $V_{CC}$  minimum is 4.5V and maximum is 5.5V.
- Maximum recommended bit rate is 250kbit/s.

### 7.2.2 Detailed Design Procedure

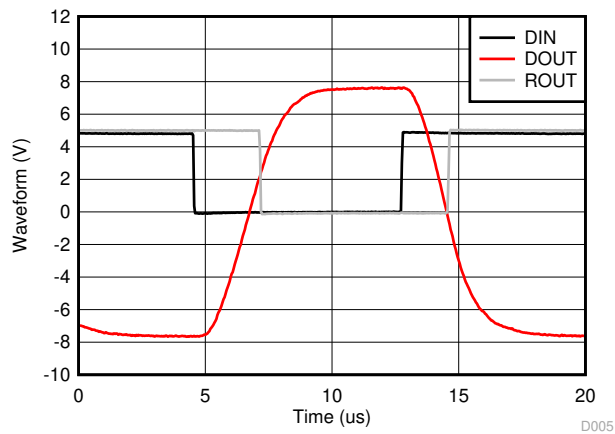
The capacitor type used for C1 – C4 is not critical for proper operation. The MAX232E requires 1µF capacitors, although capacitors up to 10µF can be used without harm. Ceramic dielectrics are suggested for capacitors. When using the minimum recommended capacitor values, make sure the capacitance value does not degrade excessively as the operating temperature varies. If in doubt, use capacitors with a larger (for example, 2×) nominal value. The capacitors' effective series resistance (ESR), which usually rises at low temperatures, influences the amount of ripple on V+ and V-.

Use larger capacitors (up to 10µF) to reduce the output impedance at V<sub>S+</sub> and V<sub>S-</sub>.

Bypass V<sub>CC</sub> to ground with at least 1 µF. In applications sensitive to power-supply noise generated by the charge pumps, decouple V<sub>CC</sub> to ground with a capacitor the same size as (or larger than) the charge-pump capacitors (C1 – C4).

### 7.2.3 Application Curve

Loopback waveform connects DOUT to RIN.



Date Rate = 120 kbit/s, C<sub>L</sub> = 1 nF

图 7-2. Loopback Waveforms

### 7.3 Power Supply Recommendations

The V<sub>CC</sub> voltage should be connected to the same power source used for logic device connected to DIN and ROUT pins. V<sub>CC</sub> should be between 4.5V and 5.5V.

## 7.4 Layout

### 7.4.1 Layout Guidelines

Keep the external capacitor traces short. This is more important on C1 and C2 nodes that have the fastest rise and fall times. Make the impedance from MAX232E ground pin and circuit board ground plane as low as possible for best ESD performance. Use wide metal and multiple vias on both sides of ground pin.

### 7.4.2 Layout Example

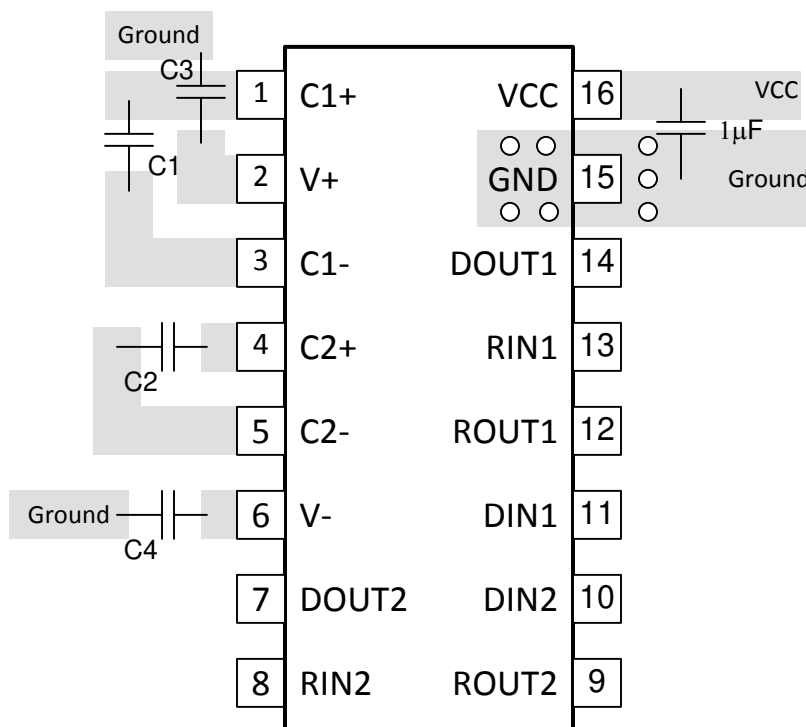


图 7-3. MAX232E Layout

## 8 Device and Documentation Support

### 8.1 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](https://www.ti.com) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

### 8.2 支持资源

**TI E2E™ 支持论坛** 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的 [《使用条款》](#)。

### 8.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

所有商标均为其各自所有者的财产。

### 8.4 静电放电警告



静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

### 8.5 术语表

**TI 术语表** 本术语表列出并解释了术语、首字母缩略词和定义。

## 9 Revision History

注：以前版本的页码可能与当前版本的页码不同

| Changes from Revision C (August 2016) to Revision D (February 2024) | Page |
|---------------------------------------------------------------------|------|
| • 将“器件信息”表更改为 <i>封装信息</i> 表.....                                    | 1    |
| • Changed the <i>Thermal Information</i> table.....                 | 5    |

| Changes from Revision B (November 2009) to Revision C (August 2016)                                                  | Page |
|----------------------------------------------------------------------------------------------------------------------|------|
| • 添加了 <i>ESD</i> 等级表、特性说明部分、器件功能模式、应用和实现部分、电源相关建议部分、布局部分、器件和文档支持部分以及机械、封装和可订购信息部分.....                               | 1    |
| • 删除了特性中的“ $\pm 30V$ 输入电平”.....                                                                                      | 1    |
| • 删除了 <i>订购信息</i> 表；请参阅数据表末尾的 POA.....                                                                               | 1    |
| • Added MIN value $\pm 3$ to "Receiver input voltage (RIN1, RIN2) row in <i>Recommended Operating Conditions</i> ... | 4    |
| • Changed $R_{\theta JA}$ values in <i>Thermal Information</i> .....                                                 | 5    |
| • Deleted table note 3 from <i>Receiver Section Electrical Characteristics</i> .....                                 | 5    |
| • Added a new row to the <i>Function Table for Each Receiver</i> .....                                               | 11   |

## 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| MAX232ECDR       | ACTIVE        | SOIC         | D                  | 16   | 2500           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | MAX232EC                | <a href="#">Samples</a> |
| MAX232EIDR       | ACTIVE        | SOIC         | D                  | 16   | 2500           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 85    | MAX232EI                | <a href="#">Samples</a> |
| MAX232EIDWR      | ACTIVE        | SOIC         | DW                 | 16   | 2000           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 85    | MAX232EI                | <a href="#">Samples</a> |
| MAX232EIN        | ACTIVE        | PDIP         | N                  | 16   | 25             | RoHS & Green    | NIPDAU                               | N / A for Pkg Type   | -40 to 85    | MAX232EIN               | <a href="#">Samples</a> |
| MAX232EINE4      | ACTIVE        | PDIP         | N                  | 16   | 25             | RoHS & Green    | NIPDAU                               | N / A for Pkg Type   | -40 to 85    | MAX232EIN               | <a href="#">Samples</a> |
| MAX232EIPWR      | ACTIVE        | TSSOP        | PW                 | 16   | 2000           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 85    | MB232EI                 | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBsolete:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

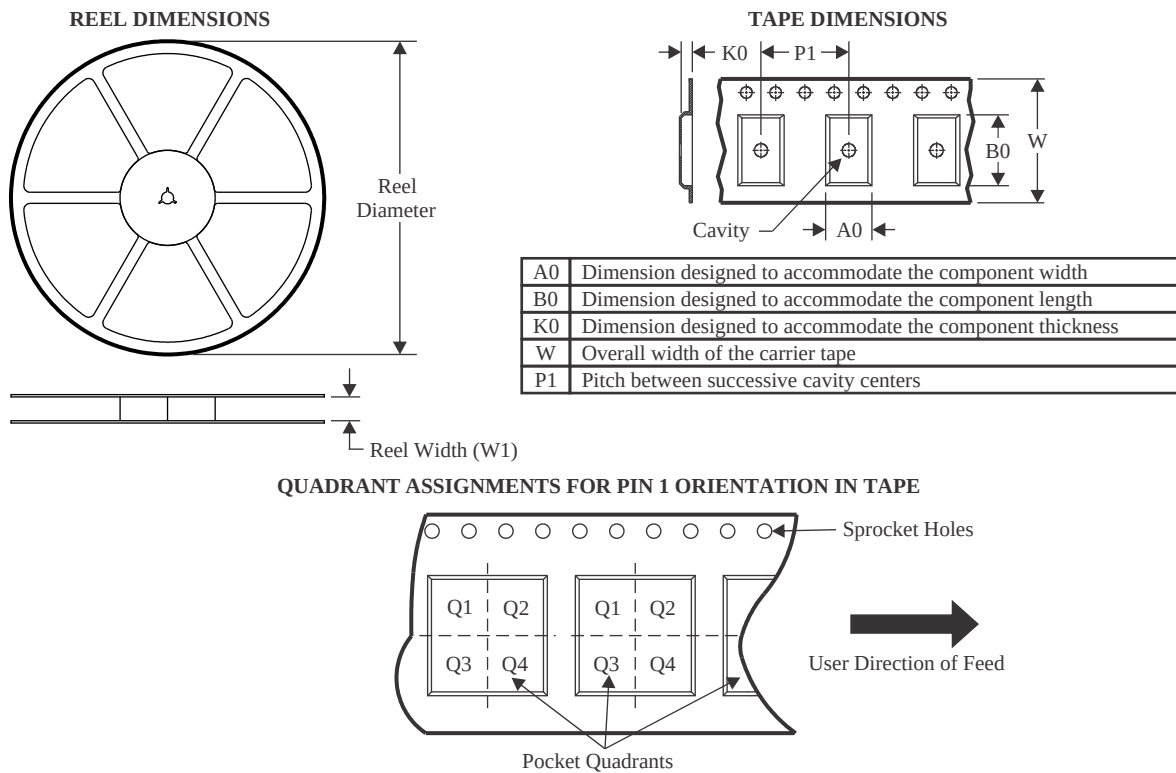
(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

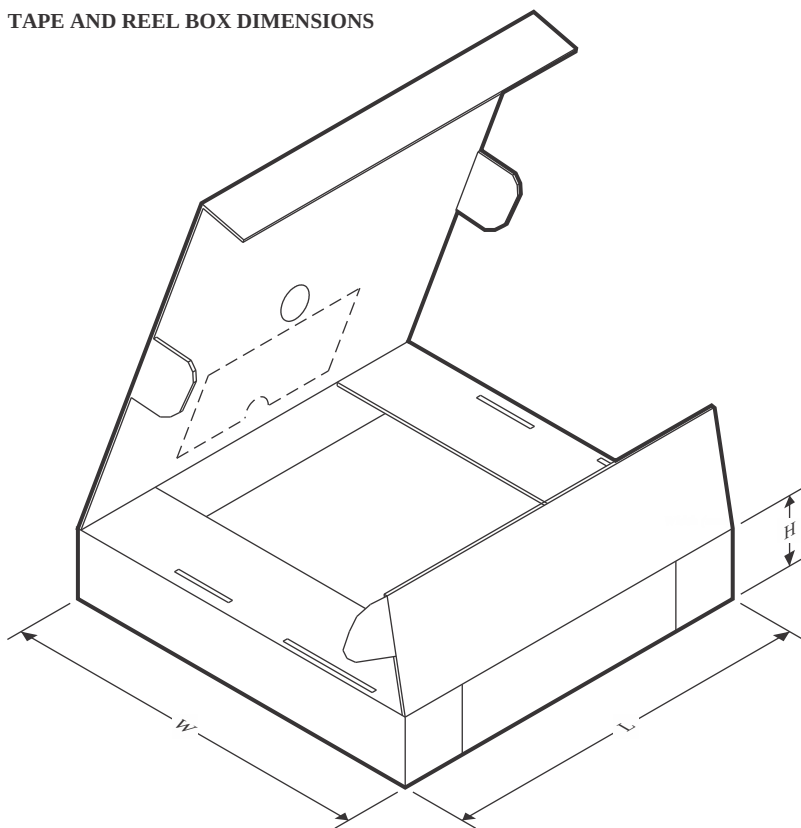
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device      | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| MAX232ECDR  | SOIC         | D               | 16   | 2500 | 330.0              | 16.4               | 6.5     | 10.3    | 2.1     | 8.0     | 16.0   | Q1            |
| MAX232EIDR  | SOIC         | D               | 16   | 2500 | 330.0              | 16.4               | 6.5     | 10.3    | 2.1     | 8.0     | 16.0   | Q1            |
| MAX232EIDWR | SOIC         | DW              | 16   | 2000 | 330.0              | 16.4               | 10.75   | 10.7    | 2.7     | 12.0    | 16.0   | Q1            |
| MAX232EIPWR | TSSOP        | PW              | 16   | 2000 | 330.0              | 12.4               | 6.9     | 5.6     | 1.6     | 8.0     | 12.0   | Q1            |

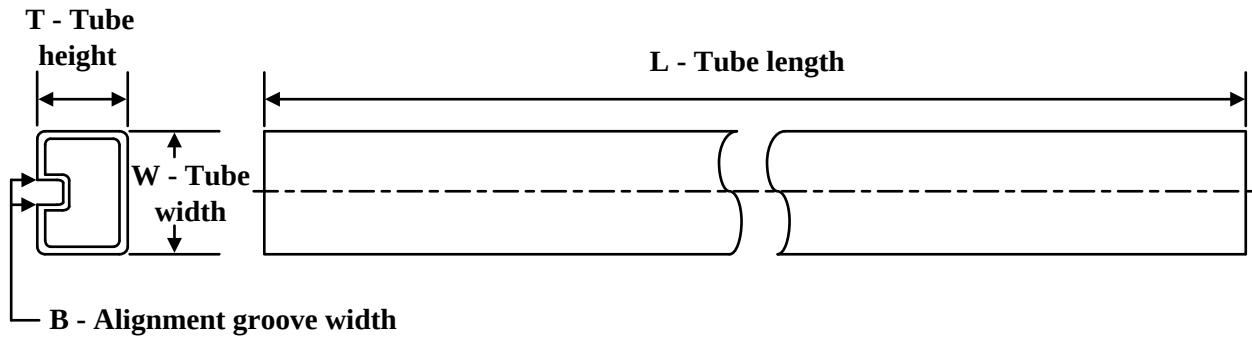
## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device      | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------|--------------|-----------------|------|------|-------------|------------|-------------|
| MAX232ECDR  | SOIC         | D               | 16   | 2500 | 356.0       | 356.0      | 35.0        |
| MAX232EIDR  | SOIC         | D               | 16   | 2500 | 356.0       | 356.0      | 35.0        |
| MAX232EIDWR | SOIC         | DW              | 16   | 2000 | 350.0       | 350.0      | 43.0        |
| MAX232EIPWR | TSSOP        | PW              | 16   | 2000 | 356.0       | 356.0      | 35.0        |

## TUBE

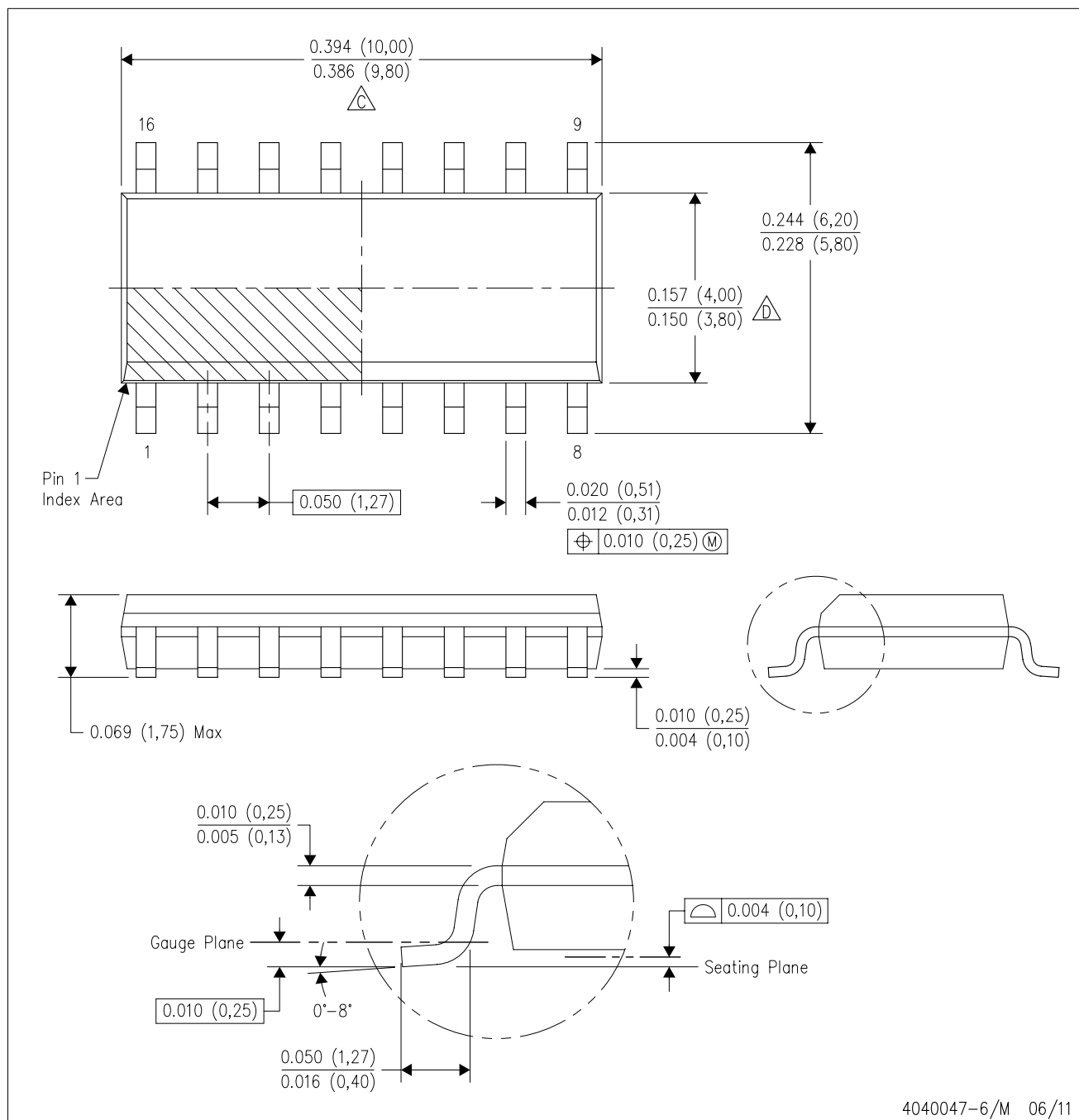


\*All dimensions are nominal

| Device      | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (μm) | B (mm) |
|-------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| MAX232EIN   | N            | PDIP         | 16   | 25  | 506    | 13.97  | 11230  | 4.32   |
| MAX232EINE4 | N            | PDIP         | 16   | 25  | 506    | 13.97  | 11230  | 4.32   |

## D (R-PDSO-G16)

# PLASTIC SMALL OUTLINE

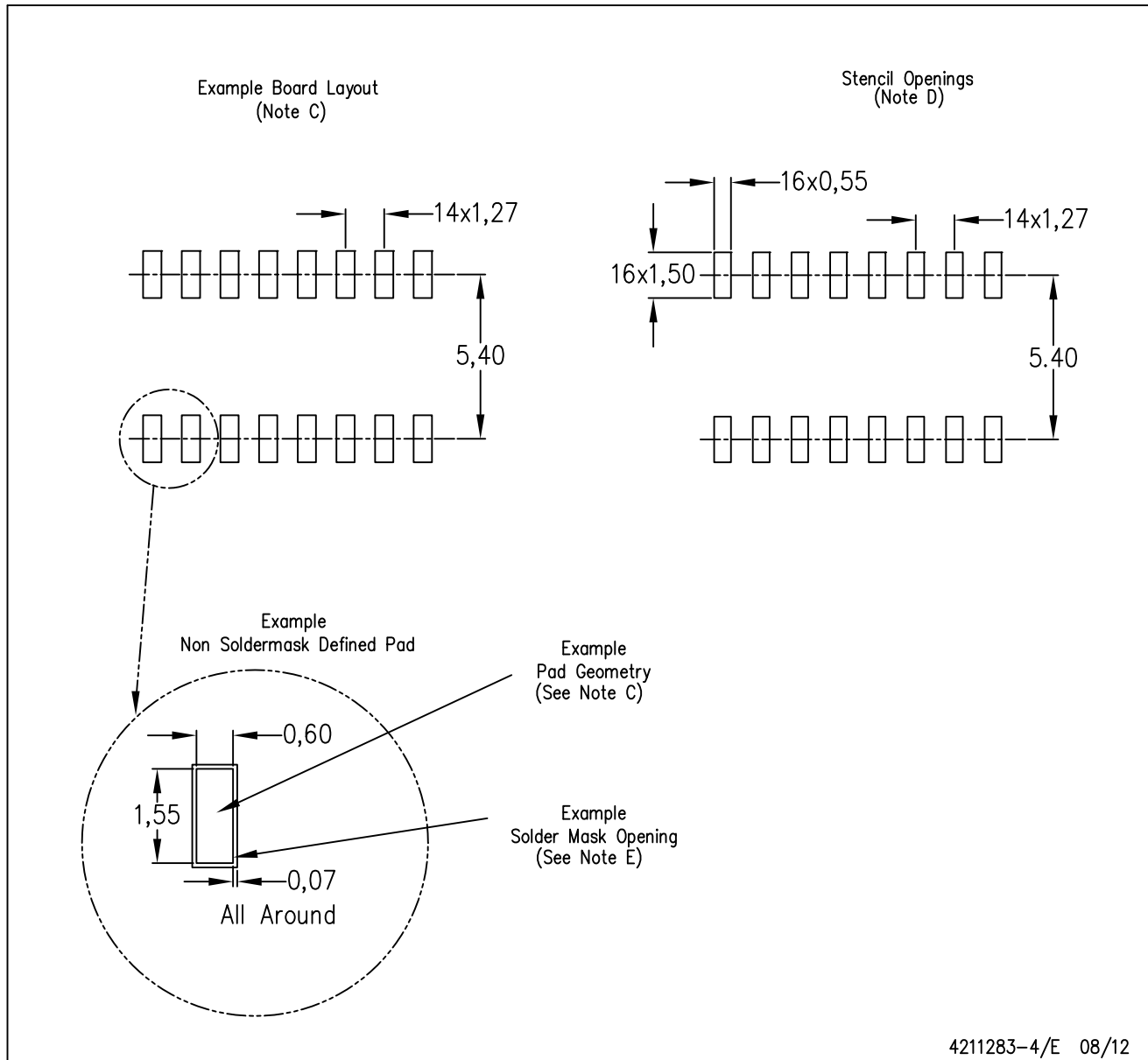


NOTES:

- A. All linear dimensions are in inches (millimeters).  
B. This drawing is subject to change without notice.  
 C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.  
 D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.  
E. Reference JEDEC MS-012 variation AC.

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

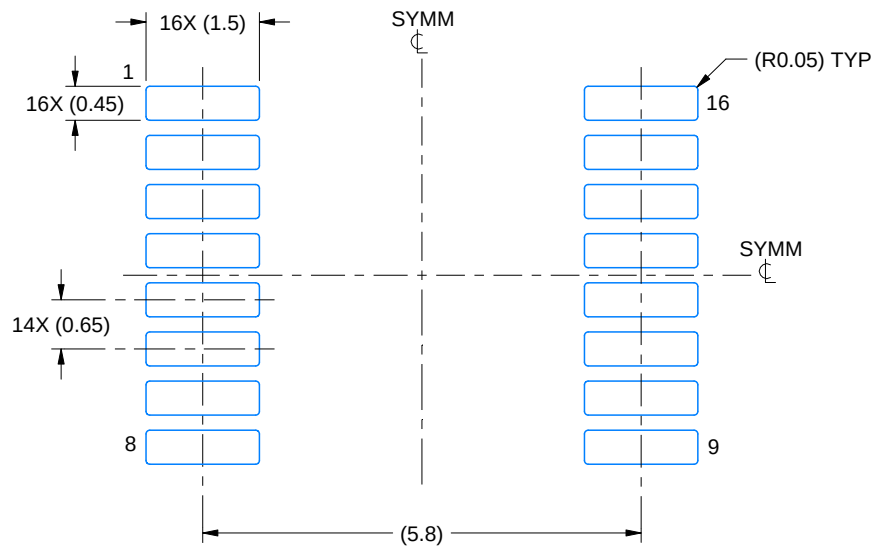


# EXAMPLE BOARD LAYOUT

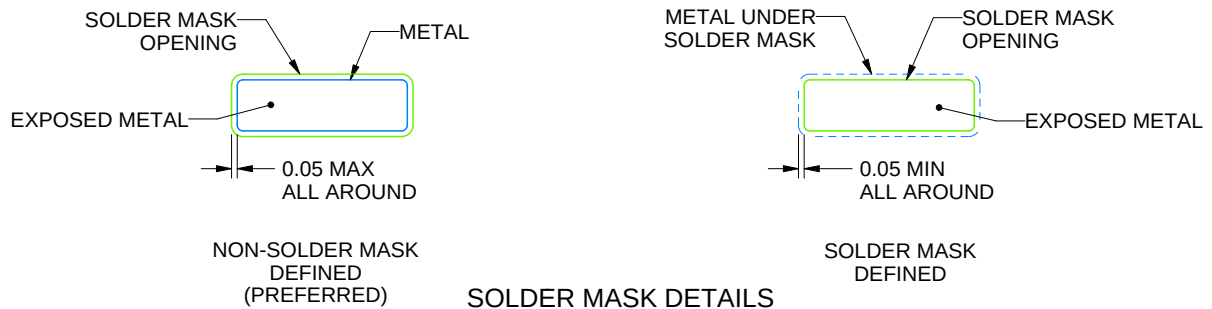
PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



4220204/A 02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

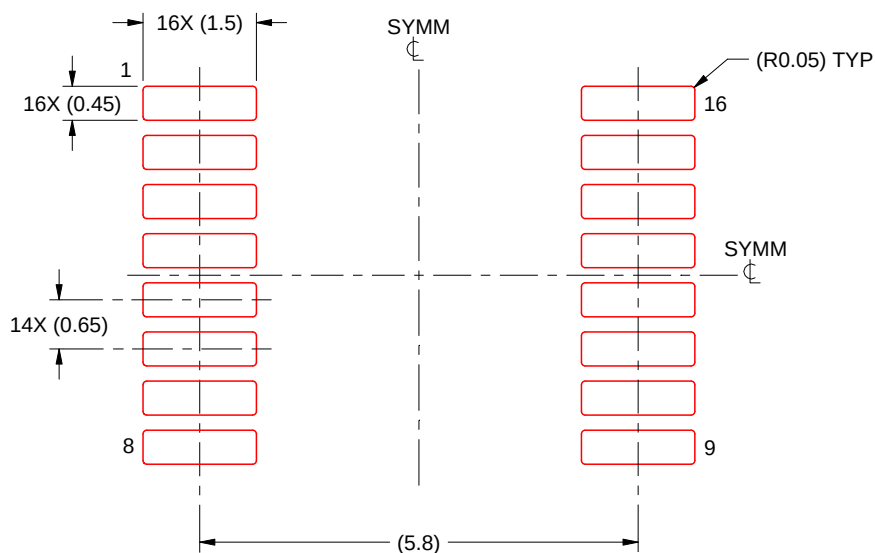
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

4220204/A 02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

## GENERIC PACKAGE VIEW

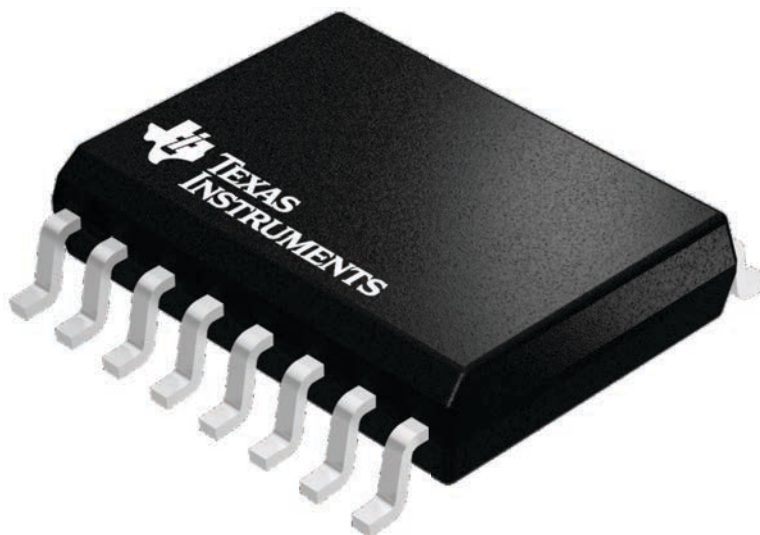
**DW 16**

**SOIC - 2.65 mm max height**

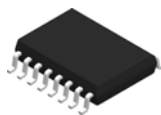
7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



4224780/A

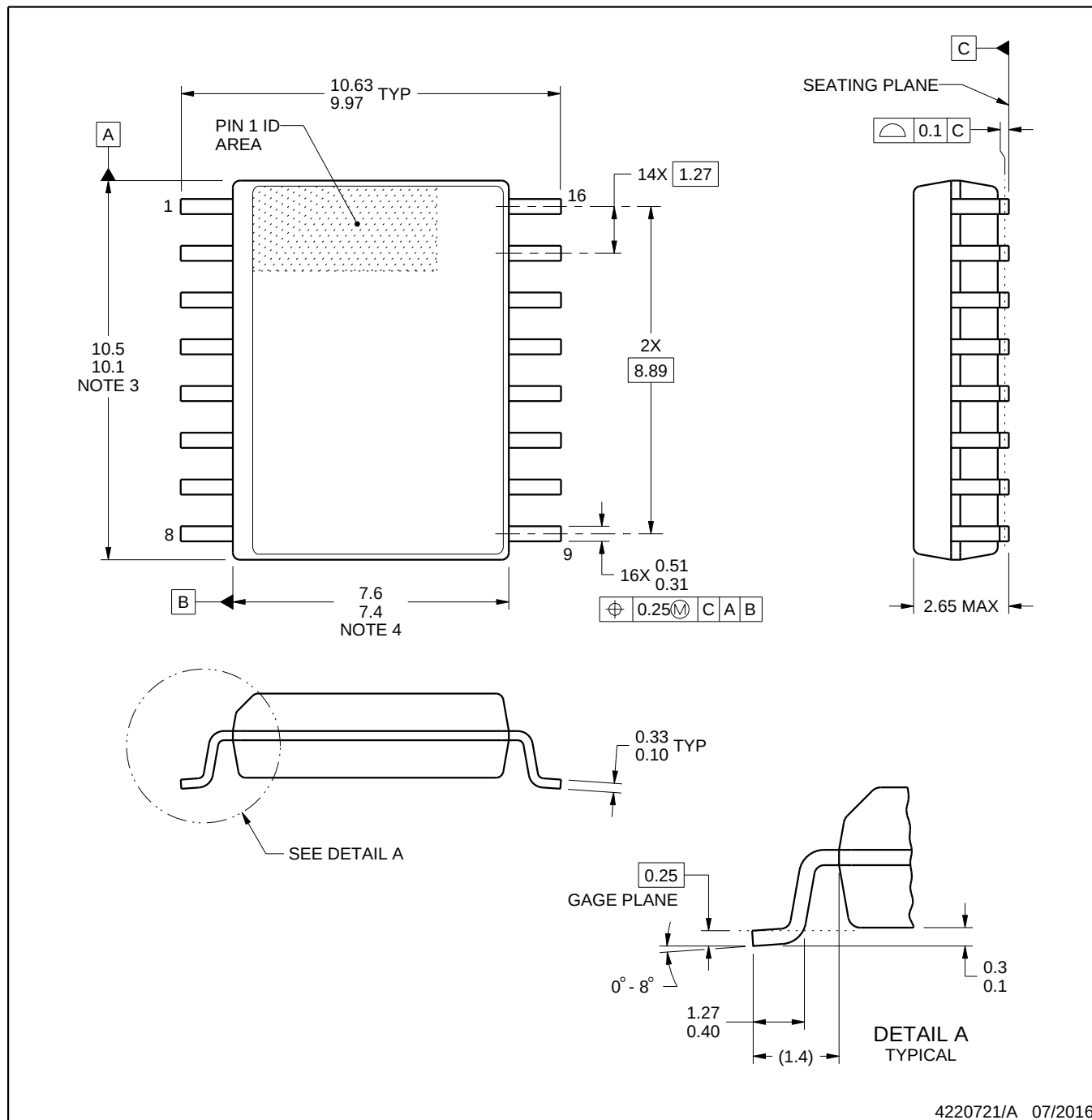


DW0016A

# PACKAGE OUTLINE

## SOIC - 2.65 mm max height

SOIC



4220721/A 07/2016

### NOTES:

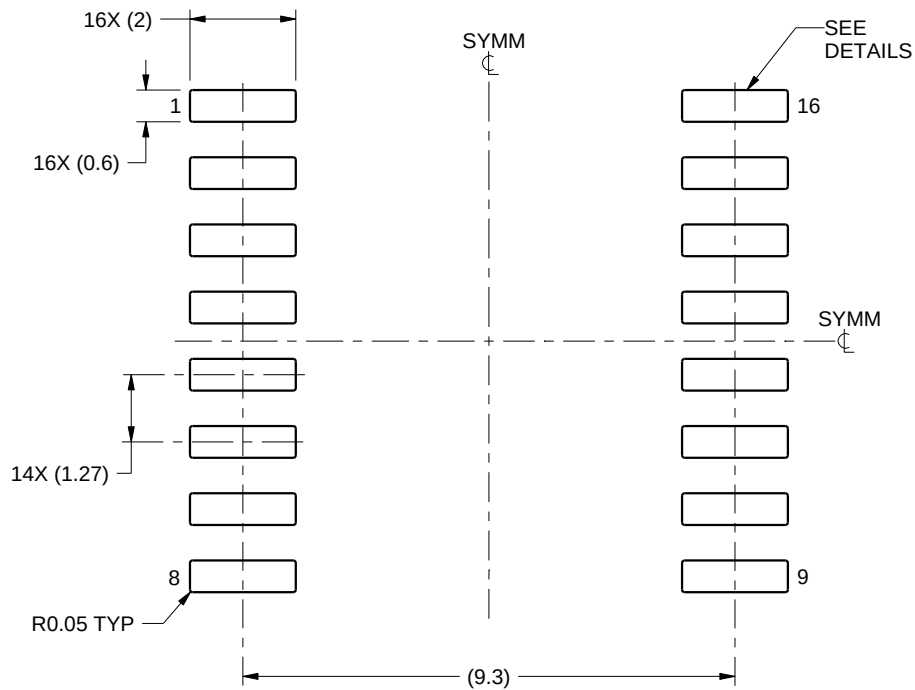
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
5. Reference JEDEC registration MS-013.

# EXAMPLE BOARD LAYOUT

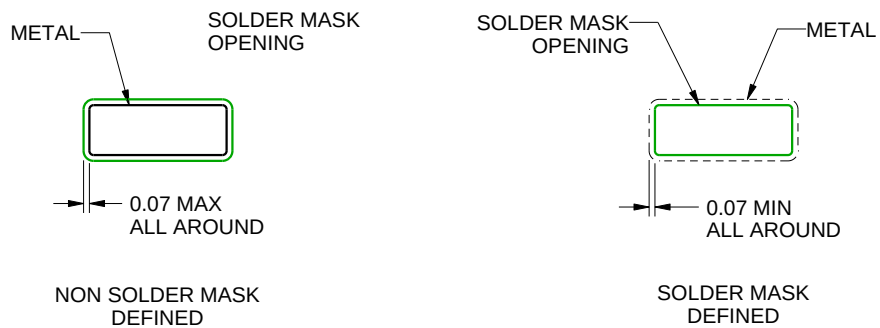
DW0016A

SOIC - 2.65 mm max height

SOIC



LAND PATTERN EXAMPLE  
SCALE:7X



SOLDER MASK DETAILS

4220721/A 07/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

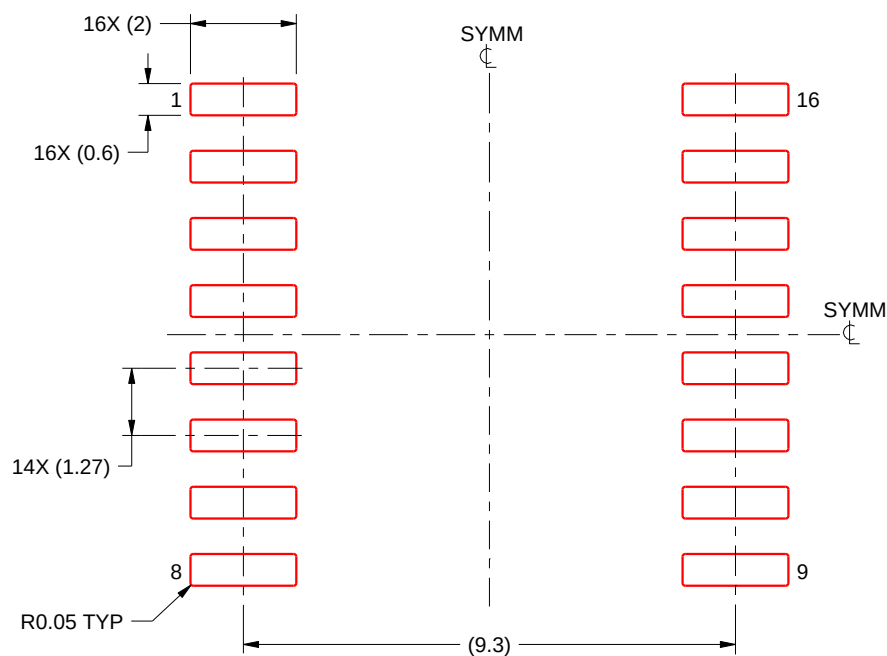
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

DW0016A

SOIC - 2.65 mm max height

SOIC



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:7X

4220721/A 07/2016

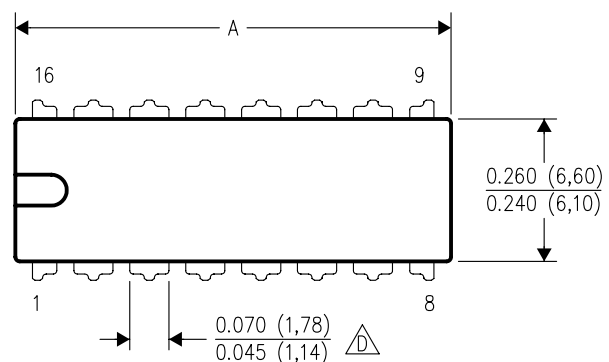
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

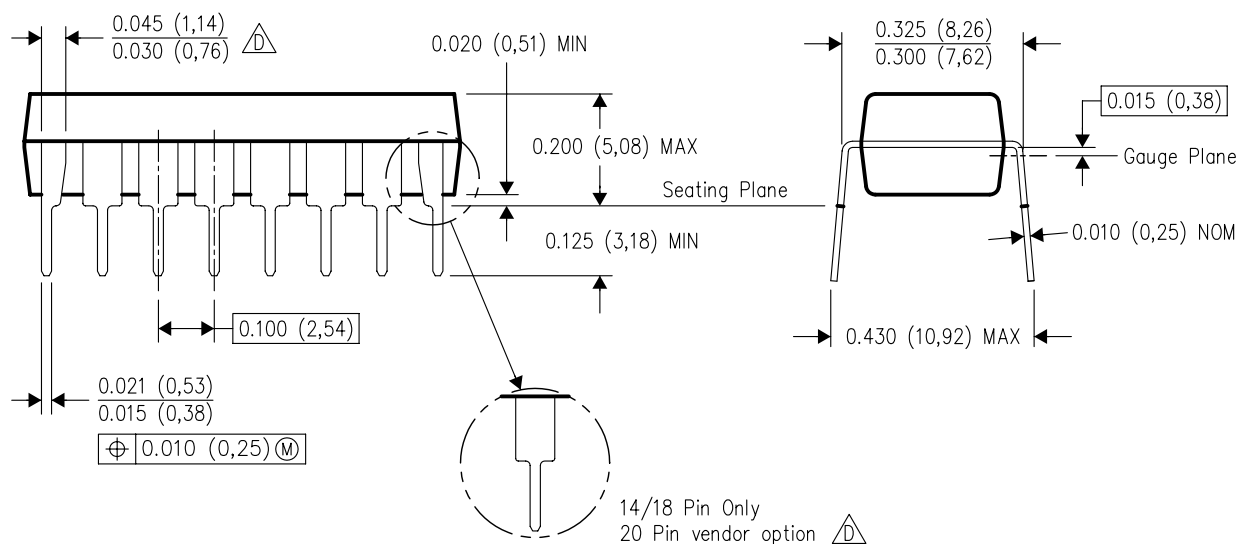
N (R-PDIP-T\*\*)

16 PINS SHOWN

## PLASTIC DUAL-IN-LINE PACKAGE



| PINS **<br>DIM      | 14               | 16               | 18               | 20               |
|---------------------|------------------|------------------|------------------|------------------|
| A MAX               | 0.775<br>(19,69) | 0.775<br>(19,69) | 0.920<br>(23,37) | 1.060<br>(26,92) |
| A MIN               | 0.745<br>(18,92) | 0.745<br>(18,92) | 0.850<br>(21,59) | 0.940<br>(23,88) |
| MS-001<br>VARIATION | AA               | BB               | AC               | AD               |



4040049/E 12/2002

NOTES:

- A. All linear dimensions are in inches (millimeters).  
B. This drawing is subject to change without notice.
-  Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).  
 The 20 pin end lead shoulder width is a vendor option, either half or full width.

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